Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/524,896	ISHIBASHI ET AL.	
Examiner	Art Unit	
Linh T. Nauvon	2627	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class .	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Consulted and received search assistant from Wayne Young.	5/9/2006	LN